RENESAS

# 3.3V CMOS 16-BIT BUFFER/DRIVER WITH 3-STATE OUTPUTS, 5 VOLT TOLERANT I/O

## FEATURES:

- Typical tsk(o) (Output Skew) < 250ps</li>
- ESD > 2000V per MIL-STD-883, Method 3015; > 200V using machine model (C = 200pF, R = 0)
- Vcc = 3.3V ± 0.3V, Normal Range
- Vcc = 2.7V to 3.6V, Extended Range
- CMOS power levels (0.4µ W typ. static)
- · All inputs, outputs, and I/O are 5V tolerant
- · Supports hot insertion
- Available in SSOP and TSSOP packages

## **DRIVE FEATURES:**

- High Output Drivers: ±24mA
- · Reduced system switching noise

## **APPLICATIONS:**

- 5V and 3.3V mixed voltage systems
- · Data communication and telecommunication systems

## FUNCTIONAL BLOCK DIAGRAM

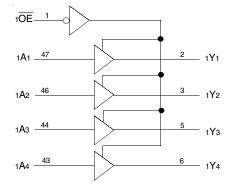
## **DESCRIPTION**:

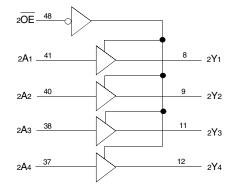
The LVC16244A 16-bit buffer/driver is built using advanced dual metal CMOS technology. The LVC16244A is designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. The device can be used as four 4-bit buffers, two 8-bit buffers, or one 16-bit buffer. This device provides true outputs and symmetrical active-low output-enable  $(\overline{OE})$  inputs.

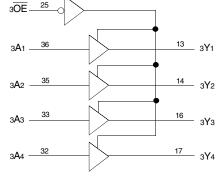
**IDT74LVC16244A** 

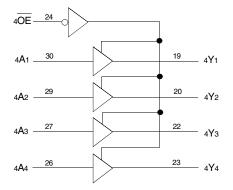
All pins of this 16-bit buffer/driver can be driven from either 3.3V or 5V devices. This feature allows the use of the device as a translator in a mixed 3.3V/5V supply system.

The LVC16244A has been designed with a  $\pm$ 24mA output driver. This driver is capable of driving a moderate to heavy load while maintaining speed performance.





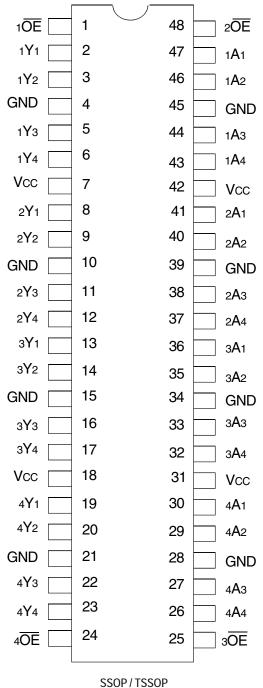




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## **JULY 2015**

## **PIN CONFIGURATION**



TOP VIEW

#### **INDUSTRIAL TEMPERATURE RANGE**

## ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

Symbol	Description	Max	Unit
VTERM <sup>(2)</sup>	Terminal Voltage with Respect to GND	–0.5 to +6.5	V
VTERM <sup>(3)</sup>	Terminal Voltage with Respect to GND	–0.5 to +6.5	V
Tstg	Storage Temperature	–65 to +150	°C
Ιουτ	DC Output Current	–50 to +50	mA
Ік Іок	Continuous Clamp Current, Vi < 0 or Vo < 0	-50	mA
lcc Iss	Continuous Current through each Vcc or GND	±100	mA

NOTES:

 Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

2. Vcc terminals.

3. All terminals except Vcc.

### CAPACITANCE (TA = +25°C, F = 1.0MHz)

Symbol	Parameter <sup>(1)</sup>	Conditions	Тур.	Max.	Unit
CIN	Input Capacitance	VIN = 0V	4.5	6	pF
Соит	Output Capacitance	Vout = 0V	6.5	8	pF
CI/O	I/O Port Capacitance	VIN = 0V	6.5	8	pF

NOTE:

1. As applicable to the device type.

## **PIN DESCRIPTION**

Pin Names	Description	
xAx	Ax Data Inputs	
x Y x 3-State Outputs		
xOE 3-State Output Enable Inputs (Active LOW)		

## FUNCTION TABLE (EACH 4-BIT BUFFER)(1)

Inp	Outputs	
xOE	хАх	хҮх
L	L	L
L	Н	Н
Н	Х	Z

NOTES:

1. H = HIGH Voltage Level

X = Don't Care

L = LOW Voltage Level

Z = High-Impedance

# DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified: Operating Condition: TA = -40 °C to +85 °C

Symbol	Parameter	Test Cor	ditions	Min.	Тур. <sup>(1)</sup>	Max.	Unit
Vih	Input HIGH Voltage Level	Vcc = 2.3V to 2.7V		1.7	-	_	V
		Vcc = 2.7V to 3.6V		2	-	_	
VIL	Input LOW Voltage Level	Vcc = 2.3V to 2.7V		_	_	0.7	V
		Vcc = 2.7V to 3.6V		_	—	0.8	
Ін	Input Leakage Current	Vcc = 3.6V	VI = 0 to 5.5V	-	-	±5	μA
lıL							
lozн	High Impedance Output Current	Vcc = 3.6V	Vo = 0 to 5.5V	_	_	±10	μA
Iozl	(3-State Output pins)						
loff	Input/Output Power Off Leakage	Vcc = 0V, VIN or Vo $\leq 5.5$ V		_	_	±50	μA
Vik	Clamp Diode Voltage	Vcc = 2.3V, IIN = -18mA		-	-0.7	-1.2	V
Vн	Input Hysteresis	Vcc = 3.3V		-	100	_	mV
ICCL	Quiescent Power Supply Current	Vcc = 3.6V	VIN = GND or VCC	-	-	10	μA
Іссн Іссz			$3.6 \le VIN \le 5.5V^{(2)}$	_	_	10	
ΔICC	Quiescent Power Supply Current Variation	One input at Vcc - 0.6V, other inputs at Vcc or GND		-	-	500	μA

NOTES:

1. Typical values are at Vcc = 3.3V, +25°C ambient.

2. This applies in the disabled state only.

# **OUTPUT DRIVE CHARACTERISTICS**

Symbol	Parameter	TestCon	ditions <sup>(1)</sup>	Min.	Max.	Unit
Vон	Output HIGH Voltage	Vcc = 2.3V to 3.6V	Іон = - 0.1mA	Vcc-0.2	—	V
		Vcc = 2.3V	Iон = - 6mA	2	_	
		Vcc = 2.3V	Іон = – 12mA	1.7	_	
		Vcc = 2.7V		2.2	_	
		Vcc = 3V	]	2.4	_	
		Vcc = 3V	Iон = - 24mA	2.2	—	
Vol	Output LOW Voltage	Vcc = 2.3V to 3.6V	IoL = 0.1mA	—	0.2	V
		Vcc = 2.3V	IoL = 6mA	—	0.4	
			IoL = 12mA	—	0.7	
		Vcc = 2.7V	IoL = 12mA	_	0.4	
		Vcc = 3V	IoL = 24mA	—	0.55	

NOTE:

1. VIH and VIL must be within the min. or max. range shown in the DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE table for the appropriate Vcc range. TA = − 40°C to + 85°C.

# **OPERATING CHARACTERISTICS**, Vcc = 3.3V ± 0.3V, TA = 25°C

Symbol	Parameter	Test Conditions	Typical	Unit
CPD	Power Dissipation Capacitance per Buffer/Driver Outputs enabled	CL = 0pF, f = 10Mhz	34	pF
Cpd	Power Dissipation Capacitance per Buffer/Driver Outputs disabled		3	

# SWITCHING CHARACTERISTICS<sup>(1)</sup>

		Vcc =	2.7V	Vcc = 3.3	V ± 0.3V	
Symbol	Parameter	Min.	Max.	Min.	Max.	Unit
tPLH	Propagation Delay	—	4.7	1.1	4.1	ns
<b>t</b> PHL	xAx to xYx					
tPZH	Output Enable Time	_	5.8	1	4.6	ns
tPZL	xOE to xYx					
tPHZ	Output Disable Time	_	6.2	1.8	5.8	ns
tPLZ	xOE to xYx					
tsk(o)	Output Skew <sup>(2)</sup>	—	—	—	1	ns

NOTES:

1. See TEST CIRCUITS AND WAVEFORMS. TA = - 40°C to + 85°C.

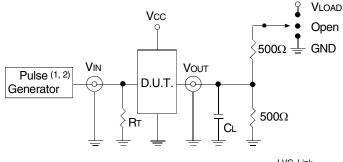
2. Skew between any two outputs of the same package and switching in the same direction.

#### IDT74LVC16244A 3.3V CMOS16-BIT BUFFER/DRIVER WITH3-STATE OUTPUTS

#### **INDUSTRIAL TEMPERATURE RANGE**

# TEST CIRCUITS AND WAVEFORMS TEST CONDITIONS

Symbol	Vcc <sup>(1)</sup> =3.3V±0.3V	Vcc <sup>(1)</sup> =2.7V	Vcc <sup>(2)</sup> =2.5V±0.2V	Unit
VLOAD	6	6	2 x Vcc	V
Vih	2.7	2.7	Vcc	V
Vτ	1.5	1.5	Vcc/2	V
Vlz	300	300	150	mV
VHZ	300	300	150	mV
CL	50	50	30	рF



#### LVC Link

#### Test Circuit for All Outputs

#### DEFINITIONS:

CL = Load capacitance: includes jig and probe capacitance.

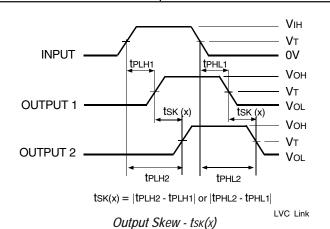
 $\mathsf{R} \tau$  = Termination resistance: should be equal to  $\mathsf{Z} \mathsf{O} \mathsf{U} \tau$  of the Pulse Generator.

#### NOTES:

1. Pulse Generator for All Pulses: Rate  $\leq$  10MHz; tF  $\leq$  2.5ns; tR  $\leq$  2.5ns. 2. Pulse Generator for All Pulses: Rate  $\leq$  10MHz; tF  $\leq$  2ns; tR  $\leq$  2ns.

### **SWITCH POSITION**

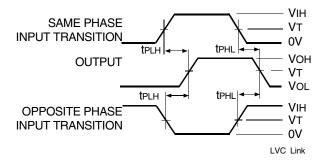
Test	Switch
Open Drain Disable Low Enable Low	Vload
Disable High Enable High	GND
All Other Tests	Open



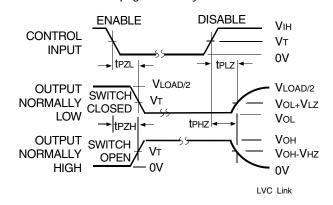
### NOTES:

1. For tsk(o) OUTPUT1 and OUTPUT2 are any two outputs.

2. For tsk(b) OUTPUT1 and OUTPUT2 are in the same bank.



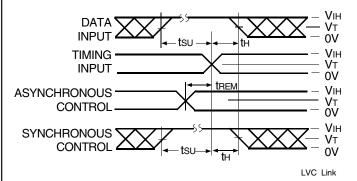
Propagation Delay

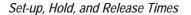


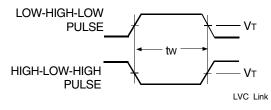
Enable and Disable Times

#### NOTE:

1. Diagram shown for input Control Enable-LOW and input Control Disable-HIGH.

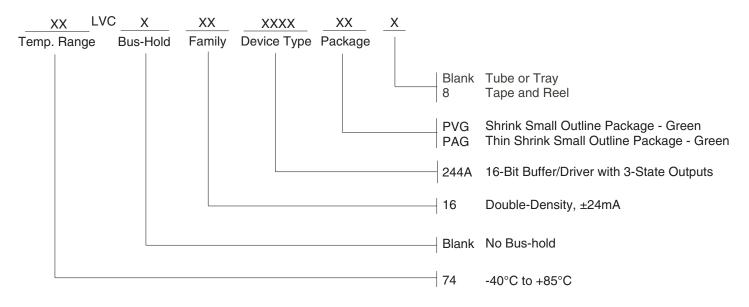






Pulse Width

### **ORDERING INFORMATION**



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